

Notice of References Cited

Application/Control No.

10/717,044

Applicant(s)/Patent Under
Reexamination
LOWN ET AL.

Examiner

LIEN TM NGO

Art Unit

3727

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,279,774	08-2001	Clute et al.	220/792
	B	US-5,531,345	07-1996	Nakamura et al.	220/3.8
	C	US-5,641,065	06-1997	Owens et al.	206/370
	D	US-5,520,301	05-1996	Sohn, Manfred	220/265
	E	US-6,269,967	08-2001	de Vries, Jef	220/669
	F	US-4,765,506	08-1988	Fishman et al.	220/792
	G	US-5,383,565	01-1995	Luch, Daniel	215/317
	H	US-6,793,096	09-2004	Seok, Chong-Chul	220/788
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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